

Product	MOSFET	Package	TO220FM
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## 1. TEST RESULT

TEST DESCRIPTION	TEST CONDITION	STANDARD	n [pcs]	Pn [pcs]
Soldering Heat Resistance	(1) 260±5°C , 10sec. , Solder-Bath	JESD22-A111	22	0
	(2) 350±10°C , 3sec. , Hand Soldering		22	0
Solderability	245±5°C , 3sec. , Solder-Bath	JESD22-B102	22	0
Thermal Shock	0°C ~ 100°C , 100cycles	-	22	0
Temperature Cycle	-55±5°C←→150±5°C , 200cycles	JESD22-A104	22	0
High Temp. High Humidity Reverse Bias	85±2°C, 85±5%RH, Specified Bias ,1000hours	JESD22-A101	22	0
Pressure Cooker Test	121±2°C , 100%RH , 203kPa , 100hours	JESD22-A102	22	0
Load Life	25°C , P <sub>D</sub> =P <sub>D</sub> max. , 1000hours	-	22	0
High Temperature Reverse Bias	T <sub>a</sub> =T <sub>stg</sub> max. , Specified Bias , 1000hours	JESD22-A108	22	0
High Temperature Storage	T <sub>stg</sub> max. , 1000hours	-	22	0
Low Temperature Storage	T <sub>stg</sub> min. , 1000hours	-	22	0
Lead strength (lead bend)	Forcing 10N, Bending 90° ,twice	EIAJ ED-4701/400 Test Method 401	22	0
Lead strength (lead pull)	Sample body fixed, pulling lead axis direction, 20N , 10±1sec.	JEITA ED-4701/400 Test Method 401	22	0
Intermittent Operation Life	T <sub>a</sub> =25°C±5°C , ON 130sec /OFF 230sec, P <sub>c</sub> max., 10,000 cycles	EIAJ ED-4701/100 Test Method 106	22	0

## 2. CRITERIA

ITEM	CONDITION	CRITERIA	
Gate-Source Leakage : I <sub>GSS</sub>	Per specification	Within two times of the standard value.	
Zero Gate Voltage Drain Current : I <sub>DSS</sub>	Per specification	Within two times of the standard value.	
Forward Transfer Admittance :  Y <sub>fs</sub>	Per specification	Changing rate of ±20%	
Physical	Visual check	No outstanding change in physical.	
Solderability	Visual check	Reflow Soldering	Immersed surface, other than the end of pin as cut-surface, must be covered by solder.
		Solder-Bath	More than 95% of the electrode must be covered with solder.

## 3. JUDGEMENT

No failure is observed from each test item.

## 4. TEST DESCRIPTION

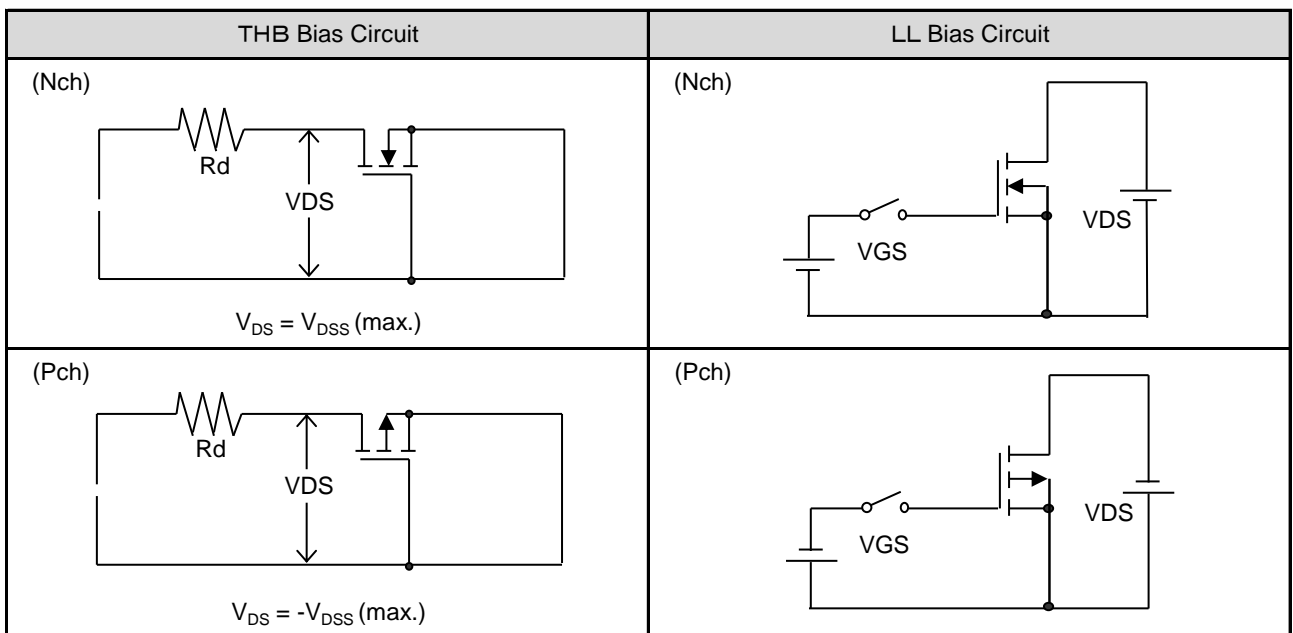
TEST DESCRIPTION		TEST CONDITION	CRITERIA
1. Soldering Heat Resistance *4	(1) *3	1) Dip the leads once into solder bath til the point 1.5mm from the package body. 260±5°C, 10±1sec Solder : Sn-3Ag-0.5Cu (Lead free) 2) After dipping, leave at room temp. for more than 2h.	• Shall be no mechanical damage. • See (*1) for criteria on electrical characteristics.
	(2)	1) Hand Soldering, 350±10°C, 3sec. 2) After testing, leave at room temp. for more than 2h.	• Shall be no mechanical damage. • See (*1) for criteria on electrical characteristics.
2. Solderability *3,*5		Immerse the leads into flux once til the point 1.5mm from the package body for 10s, Then into solder bath of 245±5°C til the point 1.5mm from the package body for 3±0.5s. Thereafter leave for natural dry at room temp. then wash off flux in 2-propanol. Solder : Sn-3Ag-0.5Cu (lead free) Flux : 2-propanol (IPA) (rosin 25wt%)	At least 95% of immersed surface, other than the end of pin as cut-surface, of must be covered by solder, which is observed through 10~20X magnifying glass.
3. Thermal Shock *6		1) Temp. & Time (Change within 10 sec.) 95~100°C (Liquid), 5min ↔ 0~5°C (Liquid), 5min 2) Freq. 100cycles. After completion of test, leave at room temp. for more than 2h.	See (*1) for criteria on electrical characteristics.
4. Temperature Cycle *6		1) Temp. & Time (Change within 5 sec.) 55°C (air), 30min ↔ 150°C (air), 30min 2) Freq. 200cycles. After completion of test, leave at room temp. for more than 2h.	See (*1) for criteria on electrical characteristics.
5. High Temp. High Humidity Reverse Bias *6		1) Ta=85±3°C, RH=75~90%, Time : 1000h 2) See (*2) for the THB bias. 3) After completion of test, leave at room temp. for more than 2h.	See (*1) for criteria on electrical characteristics.
6. Pressure Cooker Test *6		1) Ta=121°C, 100%RH, P=203KPa [2atm] 2) Time : 100h 3) After completion of test, leave at room temp. for more than 2h.	See (*1) for criteria on electrical characteristics.
7. Load Life *6		1) Ta=25±5°C, Pd/Pd(max), Time : 1000h 2) See (*2) for the THB bias. 3) After completion of test, leave at room temp. for more than 2h.	See (*1) for criteria on electrical characteristics.
8. High Temperature Reverse Bias *6		1) Ta=Tstg(max)±2°C, Time : 1000h 2) See (*2) for the THB bias. 3) After completion of test, leave at room temp. for more than 2h.	See (*1) for criteria on electrical characteristics.
9. High Temperature Storage		1) Ta=Tstg(max), Time : 1000h 2) After completion of test, leave at room temp. for more than 2h.	See (*1) for criteria on electrical characteristics.
10. Low Temperature Storage		1) Ta=Tstg(min), Time : 1000h 2) After completion of test, leave at room temp. for more than 2h.	See (*1) for criteria on electrical characteristics.
11. Lead strength (lead bend)		The sample body is fixed, and the terminal is to be bent by 90° twice, loading specified force to the axis direction.	Shall be no mechanical damage, detachment, extension between the lead and the package body.
12. Lead Strength (Lead Pull)		The sample body is fixed, and keep pulling the lead in lead axis direction with specified load for 10±1s.	Shall be no mechanical damage, detachment, extension between the lead and the package body.
13. Intermittent Operation Life		1) Ta=25±5°C, ON 130s/OFF 230s add Pc(max.). Time: 10,000 cycles, See (*2) for the LL bias. 3) After completion of test, leave at room temp. for more than 2h.	See (*1) for criteria on electrical characteristics.

**5.REMARK**

\*1 Criteria for electrical characteristics.

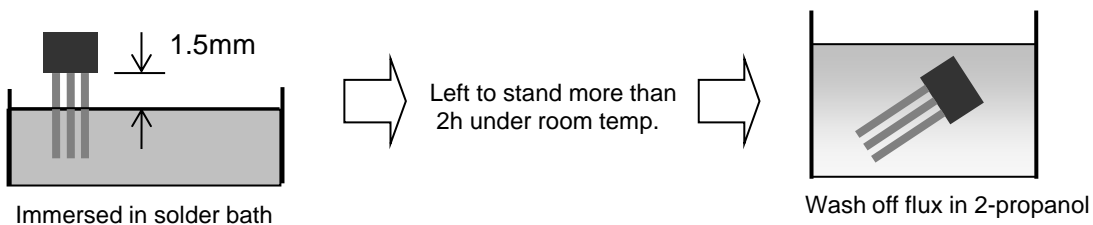
MOSFET
<ul style="list-style-type: none"> <li>• <math>I_{DSS} &gt; \text{Standard} \times 2</math></li> <li>• <math>I_{GSS} &gt; \text{Standard} \times 2</math></li> <li>• <math>\frac{\Delta Y_{fs}}{Y_{fs}} &gt; \pm 20\%</math></li> </ul>

\*2 Bias Circuit



Bias for Power devices may be reduced as per individual specification.

\*3 Method of test 1, test 2



\*4 Preconditioning : The test is carried out after it is left under the high temperature and the high humidity.(85°C,85%,168h)

\*5 Preconditioning : Aging is done with the PCT device. (105°C,100%,1.22x10<sup>5</sup>Pa,4h)

\*6 Preconditioning : Soldering heat resistance(260°C,10s) is carried out. (Reflow Soldering)

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